

<b>Notice of References Cited</b>	Application/Control No. 10/660,055	Applicant(s)/Patent Under Reexamination KNEE ET AL.	
	Examiner Sargon N. Nano	Art Unit 2157	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0016843	02-2002	Schweitzer et al.	709/227
*	C	US-2003/0177252	09-2003	Krichevski et al.	709/230
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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